## Andrew D Koehler

List of Publications by Year in descending order

Source: https://exaly.com/author-pdf/9045503/publications.pdf

Version: 2024-02-01

23 papers 1,331 citations

932766 10 h-index 19 g-index

23 all docs 23 docs citations

 $\begin{array}{c} 23 \\ times \ ranked \end{array}$ 

1808 citing authors

#	Article	IF	CITATIONS
1	Effect of GaN Substrate Properties on Vertical GaN PiN Diode Electrical Performance. Journal of Electronic Materials, 2021, 50, 3013-3021.	1.0	8
2	A Study on the Impact of Mid-Gap Defects on Vertical GaN Diodes. IEEE Transactions on Semiconductor Manufacturing, 2020, 33, 546-551.	1.4	5
3	Reduced Contact Resistance in GaN Using Selective Area Si Ion Implantation. IEEE Transactions on Semiconductor Manufacturing, 2019, 32, 478-482.	1.4	3
4	The Effect of the Gate-Connected Field Plate on Single-Event Transients in AlGaN/GaN Schottky-Gate HEMTs. IEEE Transactions on Nuclear Science, 2019, 66, 1682-1687.	1.2	10
5	GaN-On-Diamond HEMT Technology With T <sub>AVG</sub> = $176 \hat{A}^{\circ}$ C at P <sub>DC,max</sub> = $56 \text{ W/mm}$ Measured by Transient Thermoreflectance Imaging. IEEE Electron Device Letters, 2019, 40, 881-884.	2.2	52
6	Investigation of Single-Event Transients in AlGaN/GaN MIS-Gate HEMTs Using a Focused X-Ray Beam. IEEE Transactions on Nuclear Science, 2019, 66, 368-375.	1.2	9
7	Vertical power devices enabled by bulk GaN substrates. , 2019, , .		1
8	Correlation of the Spatial Variation of Single-Event Transient Sensitivity With Thermoreflectance Thermography in $\{x \in \{Al\}_{x} \in \{Ga\}_{1-x} N/GaN \in EEE Transactions on Nuclear Science, 2018, 65, 369-375.$	1.2	6
9	Ultrawideâ€Bandgap Semiconductors: Research Opportunities and Challenges. Advanced Electronic Materials, 2018, 4, 1600501.	2.6	839
10	High resistivity halide vapor phase homoepitaxial $\hat{l}^2$ -Ga2O3 films co-doped by silicon and nitrogen. Applied Physics Letters, 2018, 113, .	1.5	30
11	Electrothermal Evaluation of AlGaN/GaN Membrane High Electron Mobility Transistors by Transient Thermoreflectance. IEEE Journal of the Electron Devices Society, 2018, 6, 922-930.	1.2	14
12	A Tri-Layer PECVD SiN Passivation Process for Improved AlGaN/GaN HEMT Performance. ECS Journal of Solid State Science and Technology, 2017, 6, P58-P61.	0.9	10
13	Application of a Focused, Pulsed X-Ray Beam to the Investigation of Single-Event Transients in Al <sub>0.3</sub> Ga <sub>0.7</sub> N/GaN HEMTs. IEEE Transactions on Nuclear Science, 2017, 64, 97-105.	1.2	9
14	Vertical GaN Junction Barrier Schottky Diodes. ECS Journal of Solid State Science and Technology, 2017, 6, Q10-Q12.	0.9	33
15	High Voltage GaN Lateral Photoconductive Semiconductor Switches. ECS Journal of Solid State Science and Technology, 2017, 6, S3099-S3102.	0.9	12
16	Vertical GaN Junction Barrier Schottky Rectifiers by Selective Ion Implantation. IEEE Electron Device Letters, 2017, 38, 1097-1100.	2.2	136
17	Spatial Mapping of Pristine and Irradiated AlGaN/GaN HEMTs With UV Single-Photon Absorption Single-Event Transient Technique. IEEE Transactions on Nuclear Science, 2016, 63, 1995-2001.	1.2	20
18	Hyperspectral Electroluminescence Characterization of OFF-State Device Characteristics in Proton Irradiated High Voltage AlGaN/GaN HEMTs. ECS Journal of Solid State Science and Technology, 2016, 5, Q289-Q293.	0.9	11

#	Article	IF	CITATION
19	Vertical GaN junction barrier schottky diodes by Mg implantation and activation annealing. , 2016, , .		0
20	A Comparison of Single-Event Transients in Pristine and Irradiated <formula formulatype="inline"><tex notation="TeX">\${{m Al}_{0.3}}{{m Ga}_{0.7}}{{m N}/{m GaN}}\$</tex> </formula> HEMTs using Two-Photon Absorption and Heavy Ions. IEEE Transactions on Nuclear Science, 2015, 62, 2743-2751.	1.2	22
21	Degradation mechanisms of AlGaN/GaN HEMTs on sapphire, Si, and SiC substrates under proton irradiation. , 2014, , .		9
22	Substrate-Dependent Effects on the Response of AlGaN/GaN HEMTs to 2-MeV Proton Irradiation. IEEE Electron Device Letters, 2014, 35, 826-828.	2.2	78
23	Degradation of dynamic ON-resistance of AlGaN/GaN HEMTs under proton irradiation. , 2013, , .		14